

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/573,159 LEE ET AL.	
		Examiner	Art Unit Willmon Fridie	3724 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-1,362,871 A	12-1920	KELLY WILLIAM E	408/200
*	B	US-2,435,065 A	01-1948	ZEMPEL EDWARD A	408/182
*	C	US-3,018,675 A	01-1962	KLAGES CHRISTIAN L et al.	408/189
*	D	US-3,624,879 A	12-1971		407/101
*	E	US-3,915,585 A	10-1975	Eckle, Otto	408/183
*	F	US-4,278,372 A	07-1981	Heisner, Marvin M.	408/183
*	G	US-5,080,536 A	01-1992	Andrews, Edward A.	408/239A
*	H	US-5,125,773 A	06-1992	Miyashita et al.	408/156
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003004737 A	04-2009	Japan	SEKI et al.	B25B 11/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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